

Search Notes

Application/Control No.

10/701,706

Examiner

Susan Y. Chen

Applicant(s)/Patent under
Reexamination

BENHASE ET AL.

Art Unit

2161

SEARCHED

Class	Subclass	Date	Examiner
707	101, 200	4/27/2006	TYC
711	165	4/27/2006	TYC
714	5	4/27/2006	TYC
715	776	4/27/2006	TYC
345	440	4/27/2006	TYC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text search on East DB	4/27/2006	TYC
Palm inventer search	4/27/2006	TYC
NPL - ACM, IEEE, Google text search	4/28/2006	TYC